



IFW

In re Patent Application of

Confirmation Number: **2304**

THIES et al

Atty. Ref.: **4662-10**

Serial No. **10/533,094**

Group: **1762**

Filed: **May 23, 2005**

Examiner: **Unknown**

For: **PREPARATION OF A MECHANICALLY DURABLE
SINGLE LAYER COATING WITH ANTI-REFLECTIVE
PROPERTIES**

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November 28, 2005

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

As suggested by 37 C.F.R. 1.97, the undersigned attorney brings to the attention of the Patent and Trademark Office the references listed on the attached form PTO/SB/08a, copies of non-U.S. references being enclosed. This is not to be construed as a representation that a search has been made or that no better prior art exists, or that a reference is relevant merely because cited. A copy of the International Search Report is also enclosed.

The Examiner is requested to initial the attached form PTO/SB/08a and to return a copy of the initialed document to the undersigned as an indication that the attached references have been considered and made of record.

Respectfully submitted,

NIXON & VANDERHYE P.C.

By: _____

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**INFORMATION DISCLOSURE
CITATION**

DOCKET NO.

SERIAL NO.

4662-10

10/533,094

APPLICANT

THIES et al

(Use several sheets if necessary)

FILING DATE

May 23, 2005

GROUP

1762

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

[illegible]

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

		lbn-Elhaj et al, "Optical polymer thin films with isotropic and anisotropic nano-corrugated surface topologies", NATURE, MCMILLAN JOURNALS LTD. LONDON, GB, vol. 410, 12, 12 April 2001
		Walheim et al, "Nanophase-separated polymer films as high-performance antireflection coatings", SCIENCE, AMERICAN ASSOCIATION FOR THE ADVANCEMENT OF SCIENCE, NEW YORK, US, vol. 283, no. 5401, 22 January 1999
*Examiner		Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.